

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant	: Shun-Ichi ISHIUCHI	Group Art Unit : 2881
Appl. No.	: 10/598,248 (National Stage of PCT/JP2005/003157)	Examiner : Nikita WELLS
I.A. Filed	: February 25, 2005	Confirmation No. : 1704
For	: SUPERCRITICAL FLUID JET METHOD AND SUPERCRITICAL FLUID JET MASS ANALYSIS METHOD AND DEVICE	

## COMMENTS ON STATEMENT OF REASONS FOR ALLOWANCE

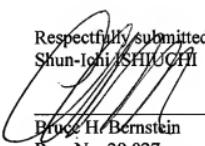
Commissioner for Patents  
U.S. Patent and Trademark Office  
Customer Service Window, Mail Stop Issue Fee  
Randolph Building  
401 Dulany Street  
Alexandria, VA 22314

Sir:

In response to the Notice of Allowability, mailed by the U.S. Patent and Trademark Office on July 17, 2008 and to the Statement of Reasons for Allowance attached thereto, Applicant wishes to clarify the record with respect to the basis for the patentability of claims in the present application. In this regard, while Applicant does not disagree with the Examiner's indication of allowability, Applicant submits that each of the claims in the present application recite a combination of features, and that the basis for patentability of each of these claims is based on the combination of features recited therein.

Should there be any questions, the Examiner is invited to contact the undersigned at the below-listed telephone number.

Respectfully submitted,  
Shun-Ichi ISHIUCHI

  
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September 18, 2008  
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